

Notice of References Cited	Application/Control No. 10/765,592	Applicant(s)/Patent Under Reexamination WEISSE ET AL.	
	Examiner Ninh H. Nguyen	Art Unit 3745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,536,143	07-1996	Jacala et al.	416/96R
	B	US-4,501,053	02-1985	Craig et al.	29/889.721
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 58148201 A	09-1983	Japan	SHIMOTORI et al.	F01D 05/18
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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